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APM2007NU

N-Channel Enhancement Mode MOSFET

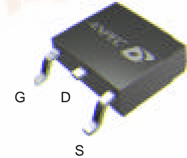
Features

- 20V/50A,
  $R_{DS(ON)}$=6mΩ (typ.) @ V_{GS}=10V
  $R_{DS(ON)}$=8mΩ (typ.) @ V_{GS}=4.5V
  $R_{DS(ON)}$=16mΩ (typ.) @ V_{GS}=2.5V
- Super High Dense Cell Design
- Reliable and Rugged
- Lead Free Available (RoHS Compliant)

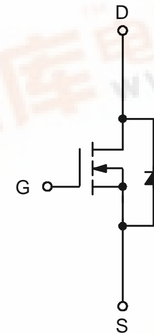
Applications

- Power Management in Desktop Computer or DC/DC Converters

Pin Description

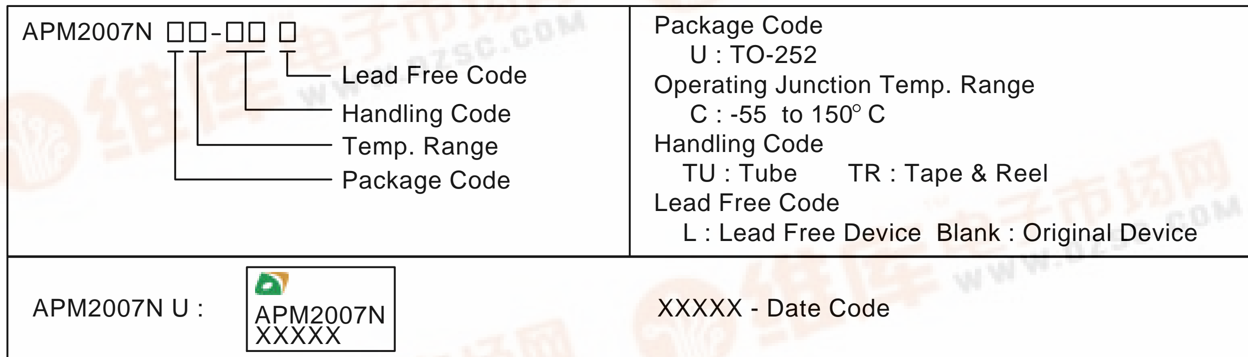


Top View of TO-252



N-Channel MOSFET

Ordering and Marking Information



APM2007N □□-□□ □ Lead Free Code Handling Code Temp. Range Package Code	Package Code U : TO-252 Operating Junction Temp. Range C : -55 to 150° C Handling Code TU : Tube TR : Tape & Reel Lead Free Code L : Lead Free Device Blank : Original Device
APM2007N U : APM2007N XXXXX	XXXXX - Date Code

Note: ANPEC lead-free products contain molding compounds and 100% matte tin plate termination finish; which are fully compliant with RoHS and compatible with both SnPb and lead-free soldiering operations. ANPEC lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J STD-020C for MSL classification at lead-free peak reflow temperature.

ANPEC reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

Absolute Maximum Ratings

Symbol	Parameter		Rating	Unit
Common Ratings (T_A=25°C Unless Otherwise Noted)				
V_{DSS}	Drain-Source Voltage		20	V
V_{GSS}	Gate-Source Voltage		±16	
T_J	Maximum Junction Temperature		150	°C
T_{STG}	Storage Temperature Range		-55 to 150	°C
I_S	Diode Continuous Forward Current	T_C=25°C	30	A
Mounted on Large Heat Sink				
I_{DP}	300µs Pulse Drain Current Tested	T_C=25°C	100	A
		T_C=100°C	80	
I_D	Continuous Drain Current	T_C=25°C	50*	A
		T_C=100°C	30	
P_D	Maximum Power Dissipation	T_C=25°C	50	W
		T_C=100°C	20	
$R_{\theta JC}$	Thermal Resistance-Junction to Case		2.5	°C/W
Mounted on PCB of 1in^2 Pad Area				
I_{DP}	300µs Pulse Drain Current Tested	T_A=25°C	100	A
		T_A=100°C	80	
I_D	Continuous Drain Current	T_A=25°C	15	A
		T_A=100°C	9	
P_D	Maximum Power Dissipation	T_A=25°C	2.5	W
		T_A=100°C	1	
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient		50	°C/W
Mounted on PCB of Minimum Footprint				
I_{DP}	300µs Pulse Drain Current Tested	T_A=25°C	100	A
		T_A=100°C	80	
I_D	Continuous Drain Current	T_A=25°C	12	A
		T_A=100°C	8	
P_D	Maximum Power Dissipation	T_A=25°C	1.6	W
		T_A=100°C	0.6	
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient		75	°C/W

Note:

* Current limited by bond wire.

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Electrical Characteristics (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition		APM2007NU			Unit
				Min.	Typ.	Max.	
Static Characteristics							
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS}=0V, I_{DS}=250μA		20			V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=16V, V_{GS}=0V				1	μA
			T_J=85°C			30	
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS}, I_{DS}=250μA		0.7	0.9	1.5	V
I_{GSS}	Gate Leakage Current	V_{GS}=±16V, V_{DS}=0V				±100	nA
$R_{DS(ON)}$ [a]	Drain-Source On-state Resistance	V_{GS}=10V, I_{DS}=30A			6	7.5	mΩ
		V_{GS}=4.5V, I_{DS}=20A			8	9.5	
		V_{GS}=2.5V, I_{DS}=15A			16	18	
Diode Characteristics							
V_{SD} [a]	Diode Forward Voltage	I_{SD}=4A, V_{GS}=0V			0.7	1.3	V
Dynamic Characteristics [b]							
R_G	Gate Resistance	V_{GS}=0V,V_{DS}=0V,F=1MHz			1.7		Ω
C_{iss}	Input Capacitance	V_{GS}=0V, V_{DS}=15V, Frequency=1.0MHz			2290		pF
C_{oss}	Output Capacitance				570		
C_{rss}	Reverse Transfer Capacitance				390		
$t_{d(ON)}$	Turn-on Delay Time	V_{DD}=10V, R_L=10Ω, I_{DS}=1A, V_{GEN}=4.5V, R_G=6Ω			17	32	ns
T_r	Turn-on Rise Time				15	29	
$t_{d(OFF)}$	Turn-off Delay Time				45	56	
T_f	Turn-off Fall Time				25	32	
Gate Charge Characteristics [b]							
Q_g	Total Gate Charge	V_{DS}=10V, V_{GS}=4.5V, I_{DS}=5A			28	35	nC
Q_{gs}	Gate-Source Charge				5.2		
Q_{gd}	Gate-Drain Charge				7.6		

Notes:

a : Pulse test ; pulse width≤300μs, duty cycle≤2%.

b : Guaranteed by design, not subject to production testing.

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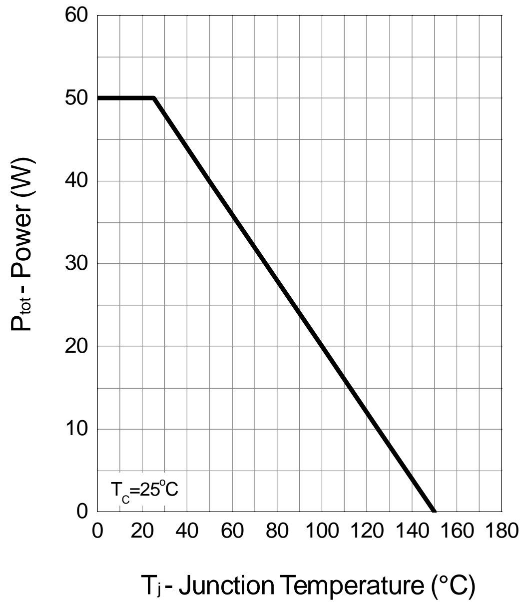
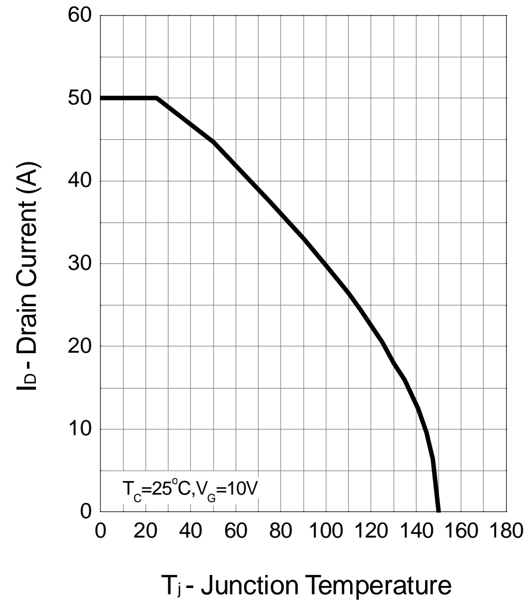
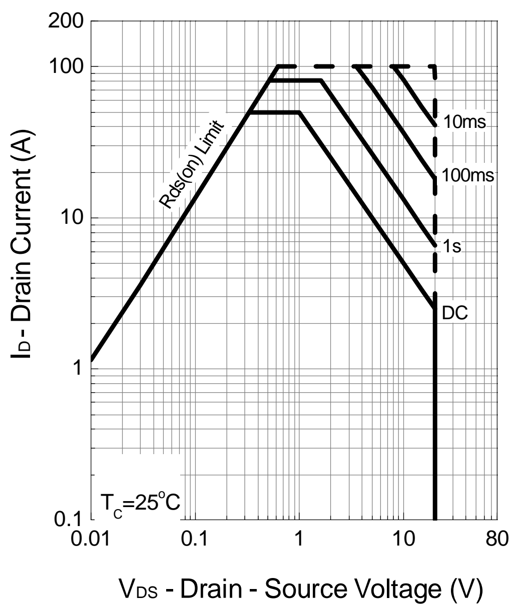
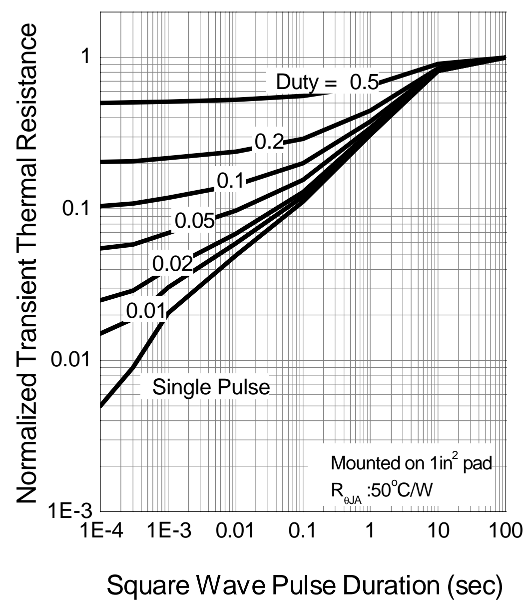
Typical Characteristics









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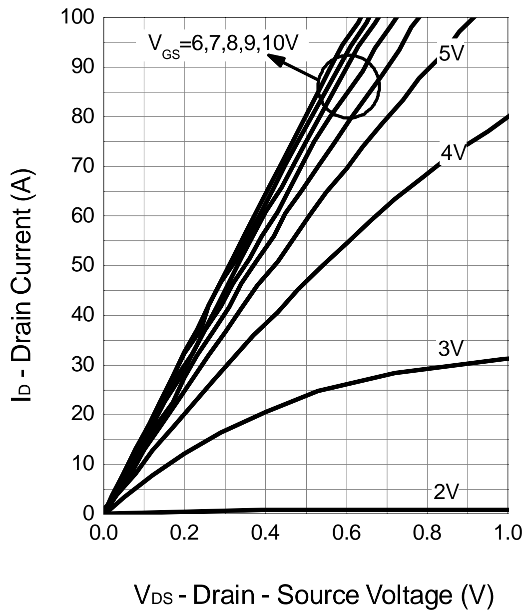
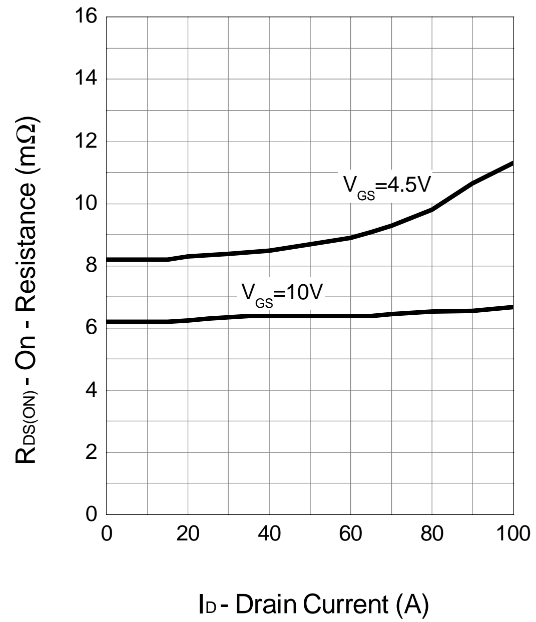
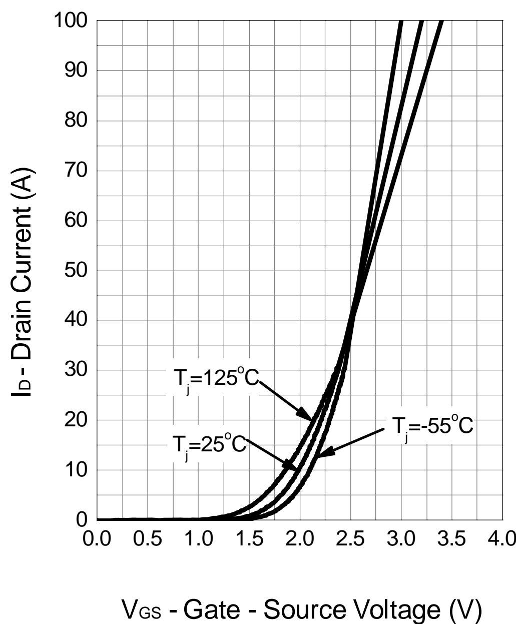
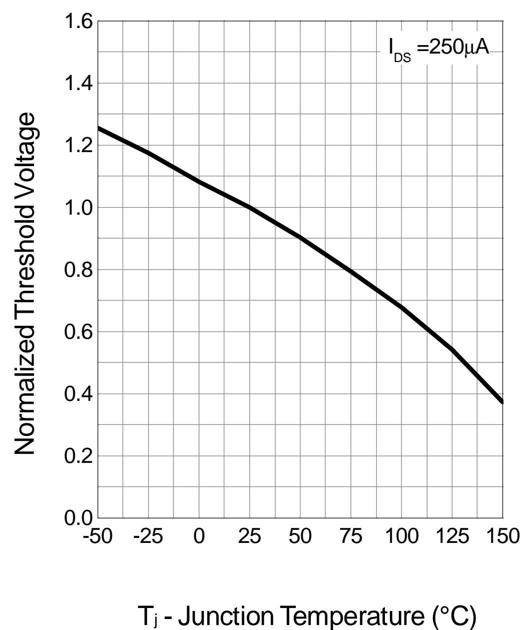
Typical Characteristics (Cont.)









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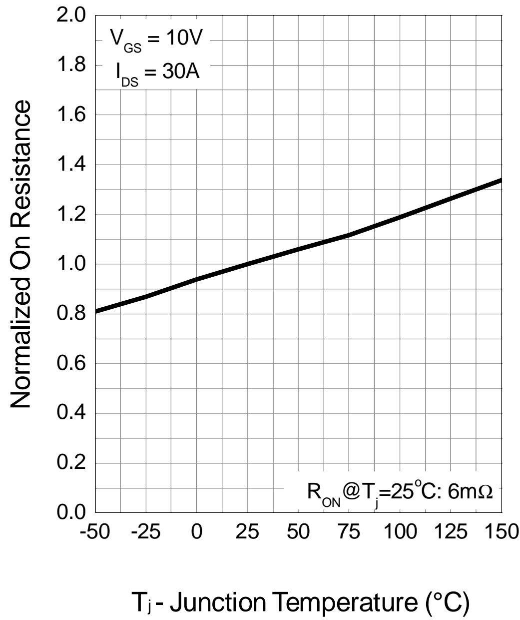

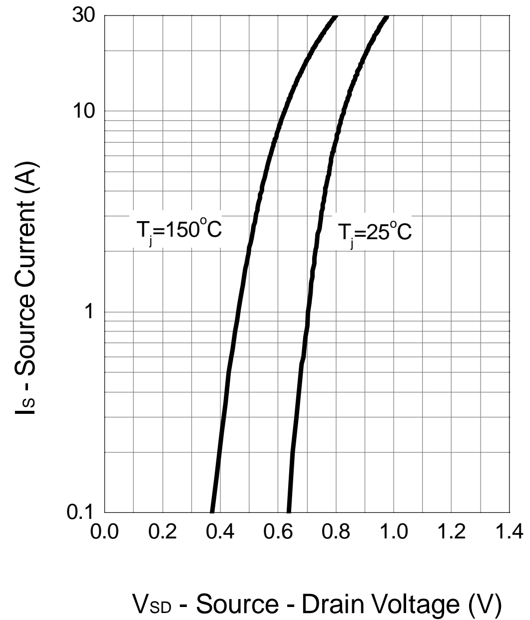

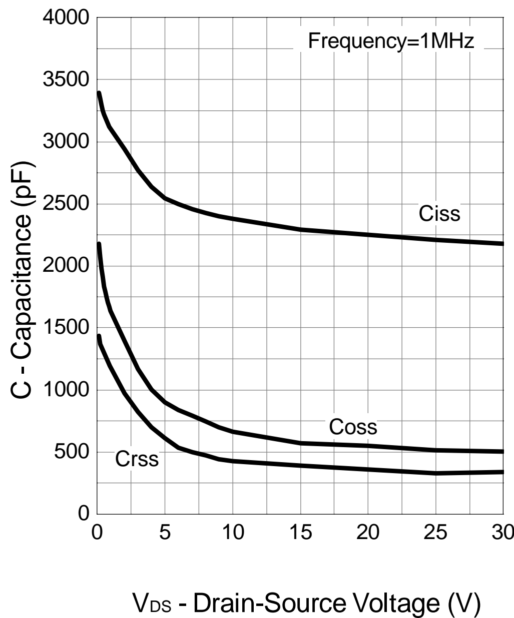

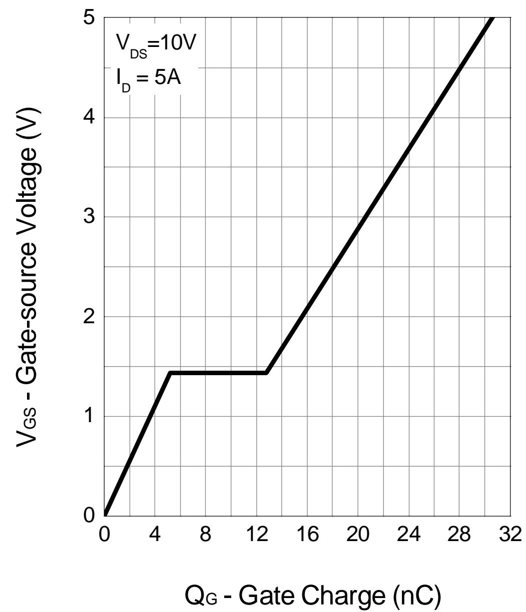

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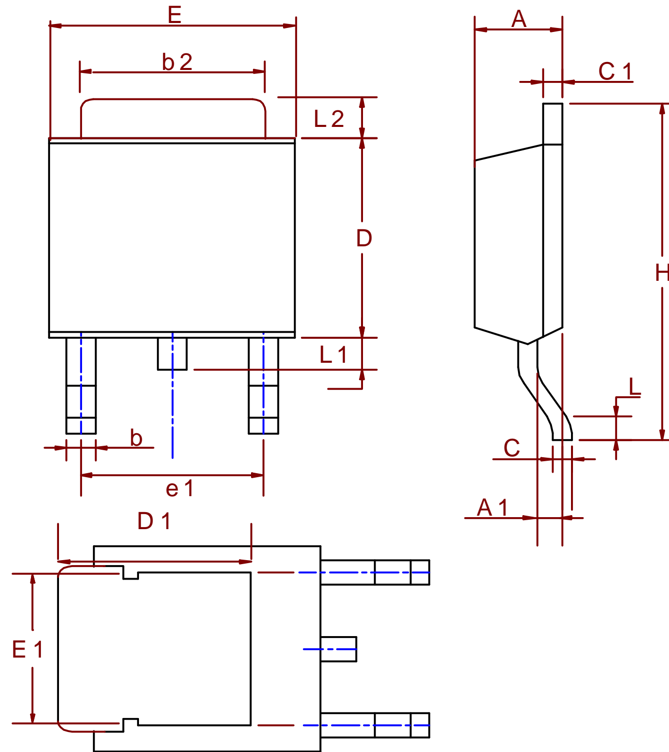
Package Information

TO-252 (Reference JEDEC Registration TO-252)

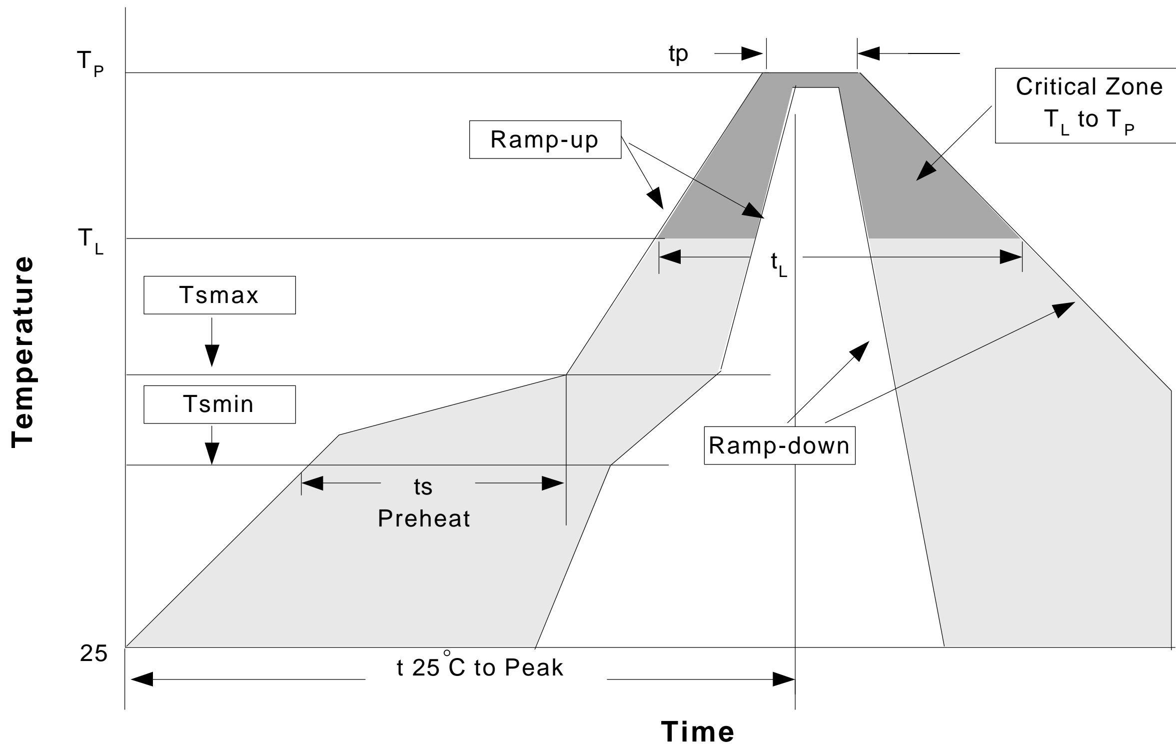


Dim	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	2.18	2.39	0.086	0.094
A1	0.89	1.27	0.035	0.050
b	0.508	0.89	0.020	0.035
b2	5.207	5.461	0.205	0.215
C	0.46	0.58	0.018	0.023
C1	0.46	0.58	0.018	0.023
D	5.334	6.22	0.210	0.245
D1	5.2 REF		0.205 REF	
E	6.35	6.73	0.250	0.265
E1	5.3 REF		0.209 REF	
e1	3.96	5.18	0.156	0.204
H	9.398	10.41	0.370	0.410
L	0.51		0.020	
L1	0.64	1.02	0.025	0.040
L2	0.89	2.032	0.035	0.080

Physical Specifications

Terminal Material	Solder-Plated Copper (Solder Material : 90/10 or 63/37 SnPb), 100%Sn
Lead Solderability	Meets EIA Specification RSI86-91, ANSI/J-STD-002 Category 3.

Reflow Condition (IR/Convection or VPR Reflow)



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate (T_L to T_P)	3°C/second max.	3°C/second max.
Preheat - Temperature Min (Tsmin) - Temperature Max (Tsmax) - Time (min to max) (ts)	100°C 150°C 60-120 seconds	150°C 200°C 60-180 seconds
Time maintained above: - Temperature (T_L) - Time (t_L)	183°C 60-150 seconds	217°C 60-150 seconds
Peak/Classificatioon Temperature (Tp)	See table 1	See table 2
Time within 5°C of actual Peak Temperature (tp)	10-30 seconds	20-40 seconds
Ramp-down Rate	6°C/second max.	6°C/second max.
Time 25°C to Peak Temperature	6 minutes max.	8 minutes max.

Notes: All temperatures refer to topside of the package .Measured on the body surface.

Classification Reflow Profiles(Cont.)

Table 1. SnPb Entectic Process – Package Peak Reflow Temperatures

Package Thickness	Volume mm^3 <350	Volume mm^3 ≥350
<2.5 mm	240 +0/-5°C	225 +0/-5°C
≥2.5 mm	225 +0/-5°C	225 +0/-5°C

Table 2. Pb-free Process – Package Classification Reflow Temperatures

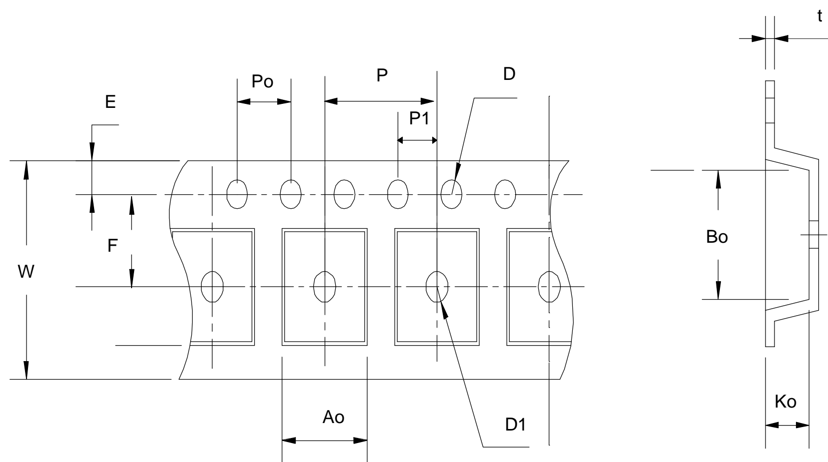
Package Thickness	Volume mm^3 <350	Volume mm^3 350-2000	Volume mm^3 >2000
<1.6 mm	260 +0°C*	260 +0°C*	260 +0°C*
1.6 mm – 2.5 mm	260 +0°C*	250 +0°C*	245 +0°C*
≥2.5 mm	250 +0°C*	245 +0°C*	245 +0°C*

*Tolerance: The device manufacturer/supplier **shall** assure process compatibility up to and including the stated classification temperature (this means Peak reflow temperature +0°C. For example 260°C+0°C) at the rated MSL level.

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	MIL-STD-883D-2003	245°C, 5 SEC
HOLT	MIL-STD-883D-1005.7	1000 Hrs Bias @125°C
PCT	JESD-22-B,A102	168 Hrs, 100%RH, 121°C
TST	MIL-STD-883D-1011.9	-65°C~150°C, 200 Cycles

Carrier Tape



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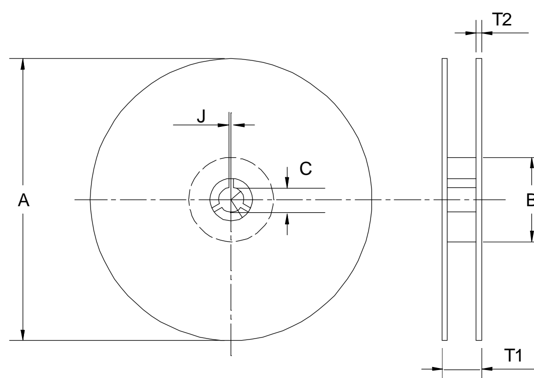
Carrier Tape(Cont.)



Application	A	B	C	J	T1	T2	W	P	E
TO-252	330 ±3	100 ± 2	13 ± 0. 5	2 ± 0.5	16.4 + 0.3 -0.2	2.5± 0.5	16+ 0.3 - 0.1	8 ± 0.1	1.75± 0.1
	F	D	D1	Po	P1	Ao	Bo	Ko	t
	7.5 ± 0.1	1.5 +0.1	1.5± 0.25	4.0 ± 0.1	2.0 ± 0.1	6.8 ± 0.1	10.4± 0.1	2.5± 0.1	0.3±0.05

(mm)

Cover Tape Dimensions

Application	Carrier Width	Cover Tape Width	Devices Per Reel
TO- 252	16	13.3	2500

Customer Service

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